

TWO MEASUREMENTS ARE SUFFICIENT TO CERTIFY

HIGH-DIM ENTANGLEMENT

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IQOQI Vienna



ENTANGLEMENT
AS THE CORNERSTONE
OF QUANTUM COMMUNICATIONS

BUT WHY HIGH-DIM?

GOING BEYOND QUBITS

ENHANCED SECURITY FOR QKD

INCREASED CHANNEL CAPACITY

HIGHER NOISE RESISTANCE

HIGH-DIM ENTANGLEMENT
FOR FREE

EFFICIENT

CERTIFICATION

STATE
ASSUMPTION-FREE

UNTRUSTED SOURCE



DEVICE DEPENDENT



1) WHICH STATE IS GENERATED?

FIDELITY BOUNDS

2) HOW ENTANGLED IS THE STATE?

SCHMIDT NUMBER WITNESS

MEASURE OF ENTANGLEMENT DIMENSIONALITY: SCHMIDT NUMBER

MINIMUM NUMBER OF LEVELS NEEDED TO REPRESENT A STATE AND ITS CORRELATIONS IN ANY BASIS

$$|\Psi\rangle = \sum_{m=0}^{k-1} \lambda_m |mm\rangle$$

$$k_{\max} = d \rightarrow \text{LOCAL DIMENSION}$$

MEASURE OF ENTANGLEMENT DIMENSIONALITY: SCHMIDT NUMBER

MINIMUM NUMBER OF LEVELS NEEDED TO REPRESENT A STATE AND ITS CORRELATIONS IN ANY BASIS

$$k(\rho) = \inf_{\mathcal{D}(\rho)} \left\{ \max_{|\psi_i\rangle \in \mathcal{D}(\rho)} \{ \text{rank} (\text{Tr}_B |\psi_i\rangle \langle \psi_i|) \} \right\}$$

$$k_{\max} = d \rightarrow \text{LOCAL DIMENSION}$$

STARTING POINT

$$F(\rho, \Phi) \leq B_k(\Phi)$$

STARTING POINT

$$|\Phi_{(k')}\rangle = \sum_{m=0}^{k'-1} \lambda_m |mm\rangle$$

$$F(\rho_{(k)}, |\Phi_{(k')}\rangle) \leq \underbrace{\sum_{m=0}^{k-1} \lambda_m^2}_{B_k(\Phi_{(k')})}$$

TWO MEASUREMENTS

$$\tilde{F}(\rho, \Phi) \leq F(\rho, \Phi) \leq B_k(\Phi)$$

WITHOUT ASSUMPTIONS ON ρ

$$|\Phi\rangle = \sum_{m=0}^{k-1} \lambda_m |mm\rangle$$

$$F(\rho, \Phi) = \sum_m \lambda_m^2 \langle mm | \rho | mm \rangle + \sum_{m, n \neq m} \lambda_m \lambda_n \langle mm | \rho | nn \rangle$$

$$= F_{\text{diag}}(\rho, \Phi) + F_{\text{off-diag}}(\rho, \Phi)$$

$$\geq F_{\text{diag}}(\rho, \Phi) + \tilde{F}_{\text{diag}}(\rho, \Phi) + \tilde{F}_{\text{tilted}}(\rho, \Phi)$$

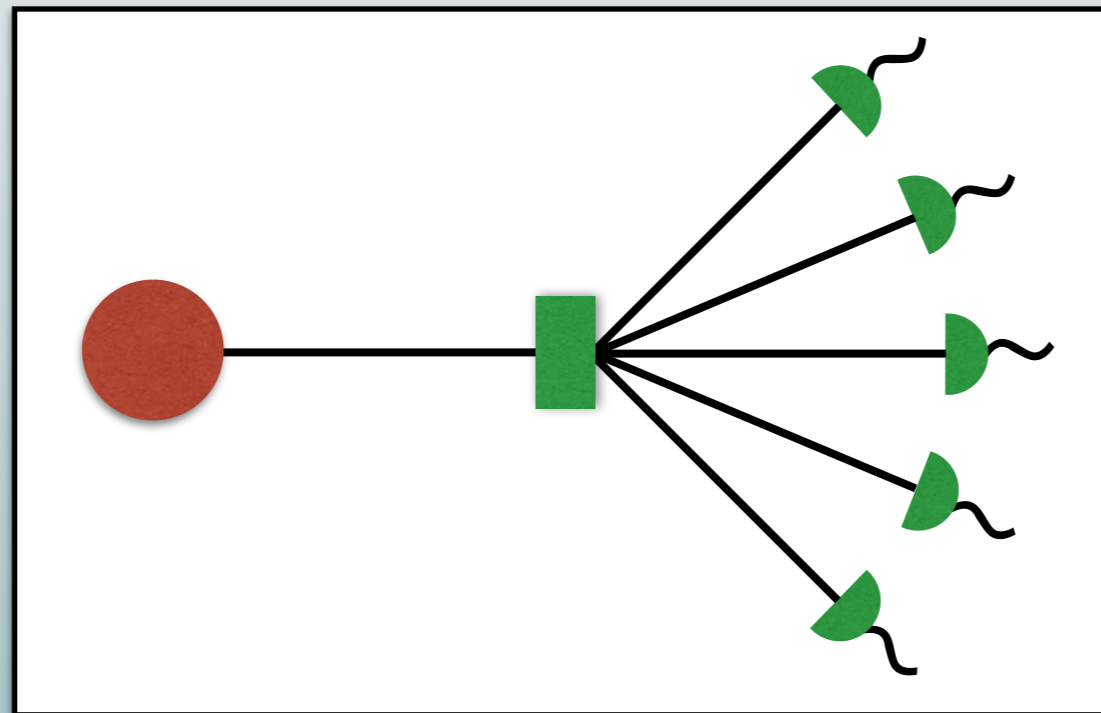
FIRST
MEASUREMENT

SECOND
MEASUREMENT

$$\geq \tilde{F}(\rho, \Phi)$$

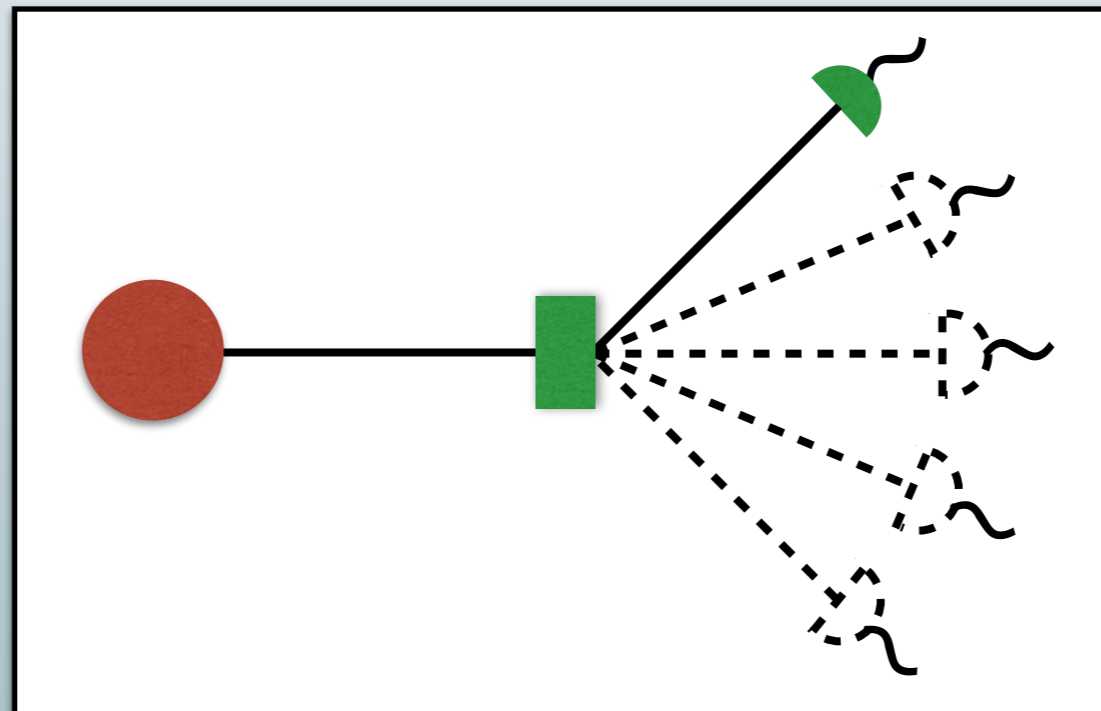
WHAT COUNTS AS A MEASUREMENT?

IMPLEMENTING A d -OUTCOME MEASUREMENT

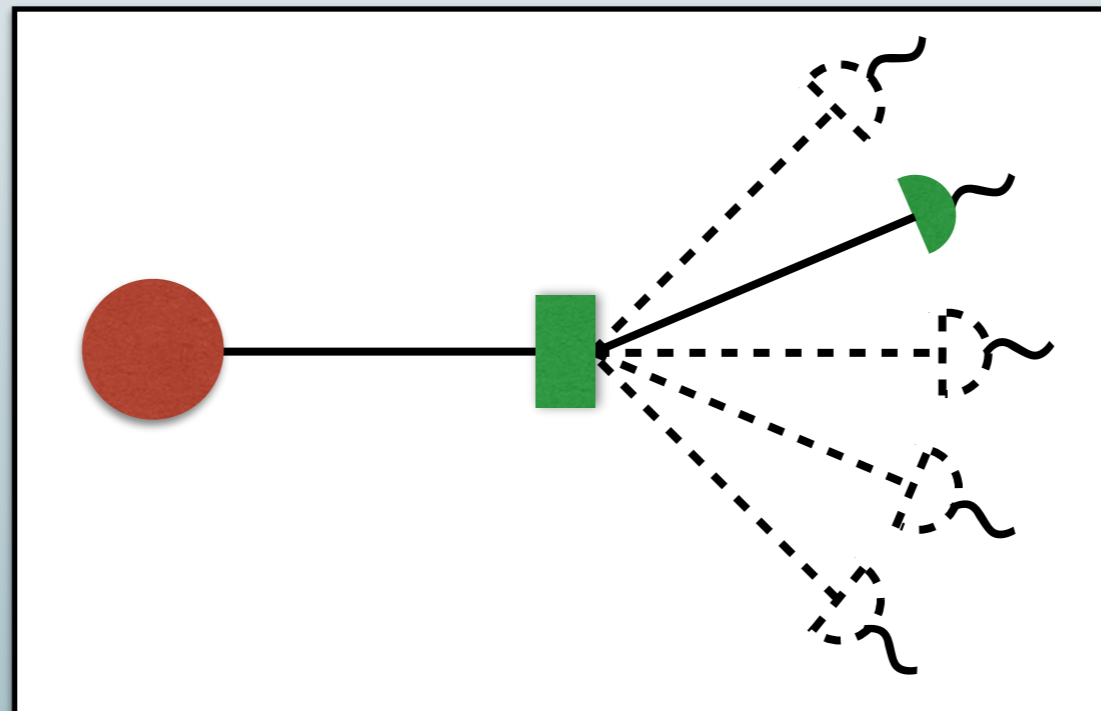


d -outcomes

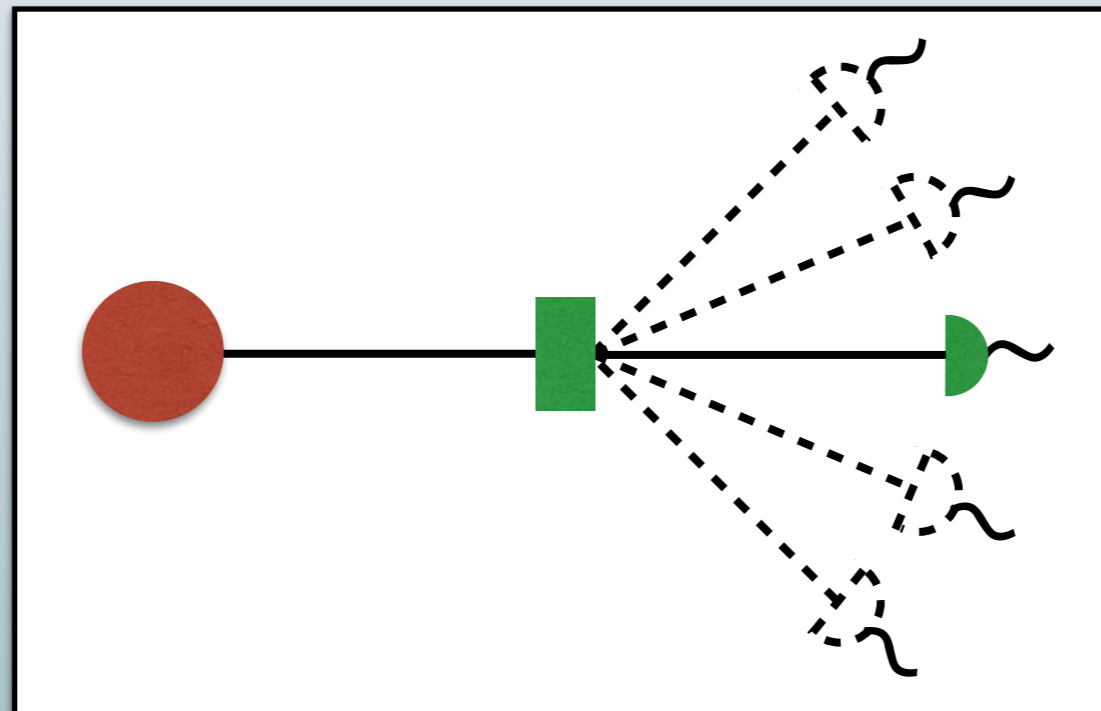
IMPLEMENTING A d -OUTCOME MEASUREMENT



IMPLEMENTING A d -OUTCOME MEASUREMENT

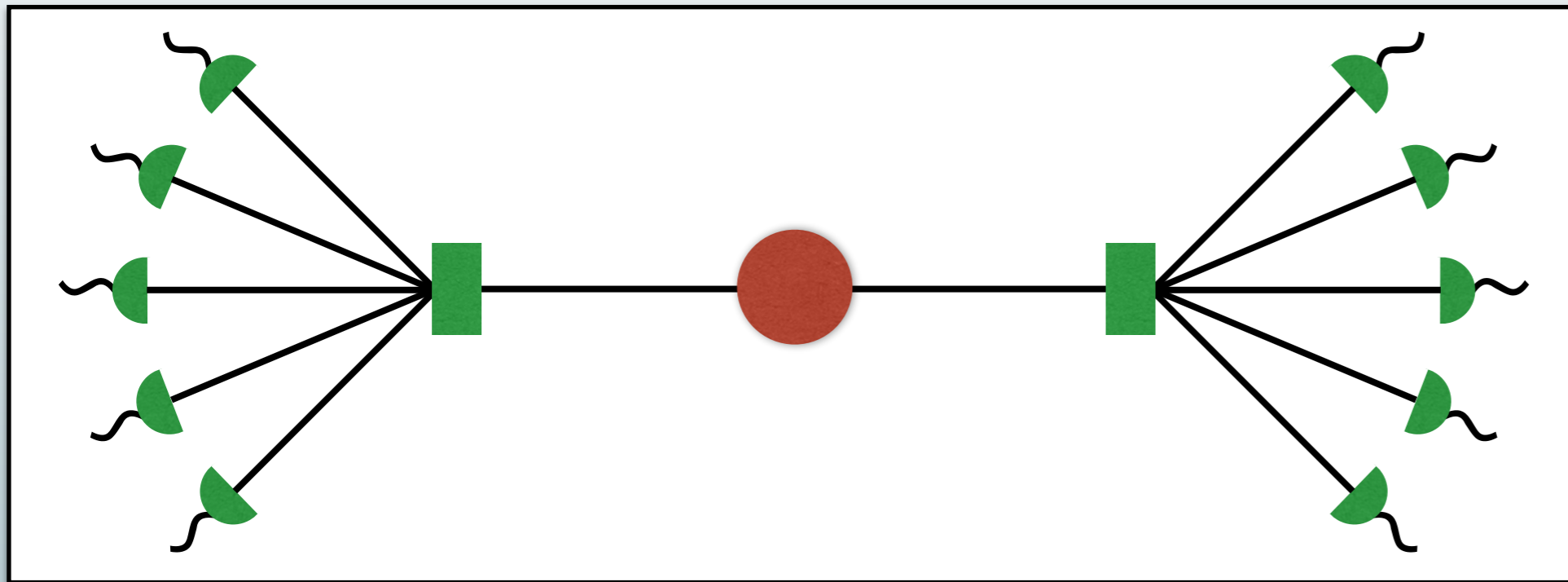


IMPLEMENTING A d -OUTCOME MEASUREMENT



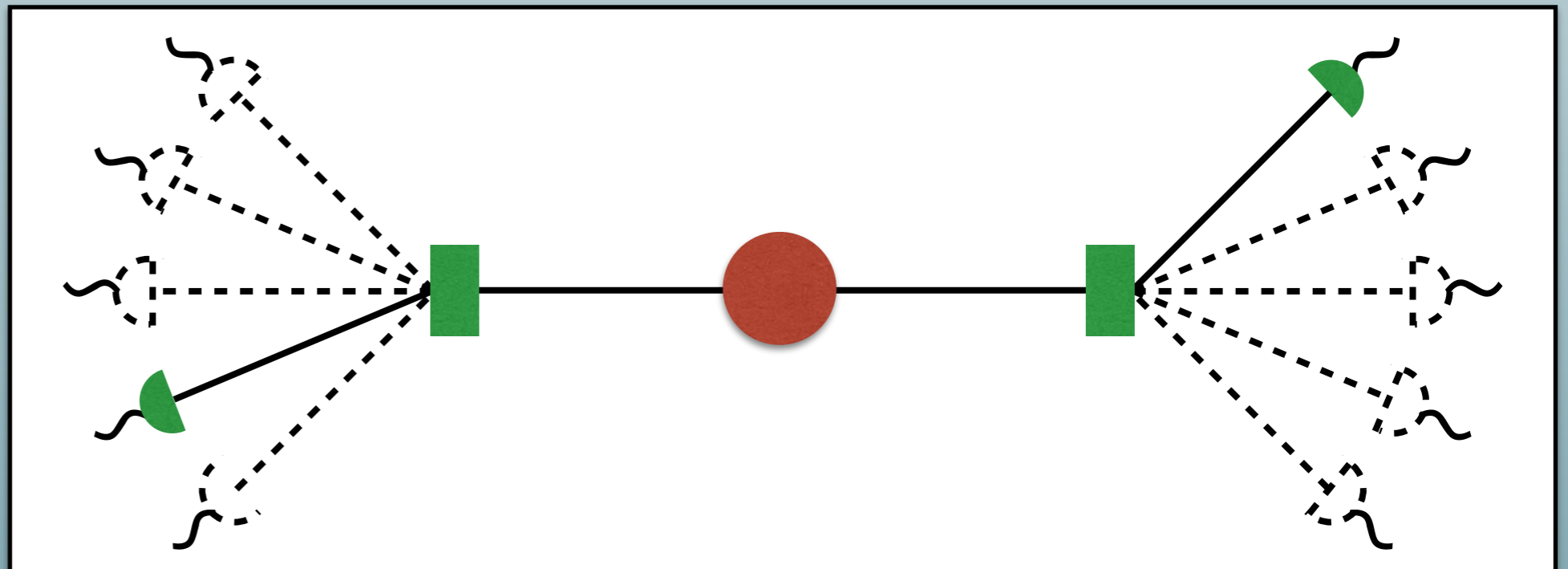
single outcome

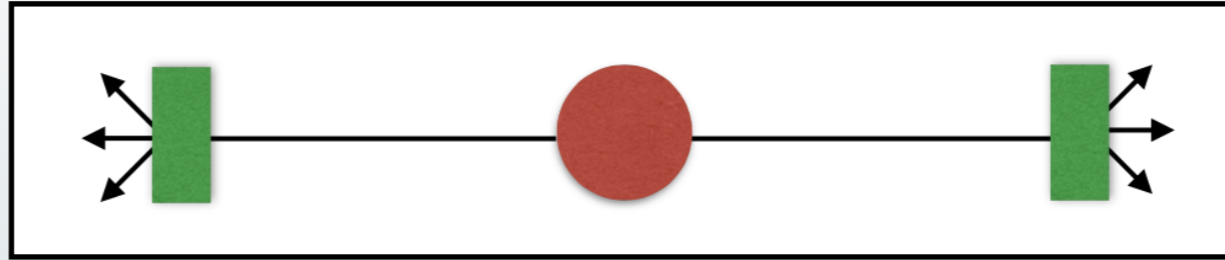
IMPLEMENTING A d -OUTCOME MEASUREMENT



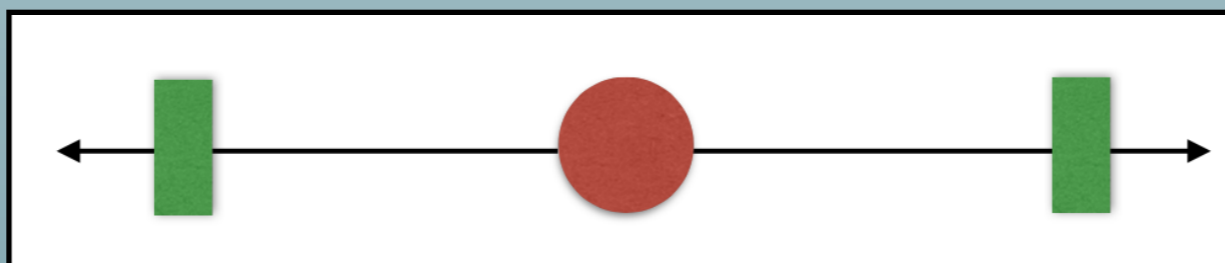
one setting

d^2 settings





Number of outcomes	Tomography	Fidelity	Our Method
d	$(d+1)^2$	$d+1$	2
single	$(d+1)^2 d^2$	$(d+1) d^2$	$2d^2$

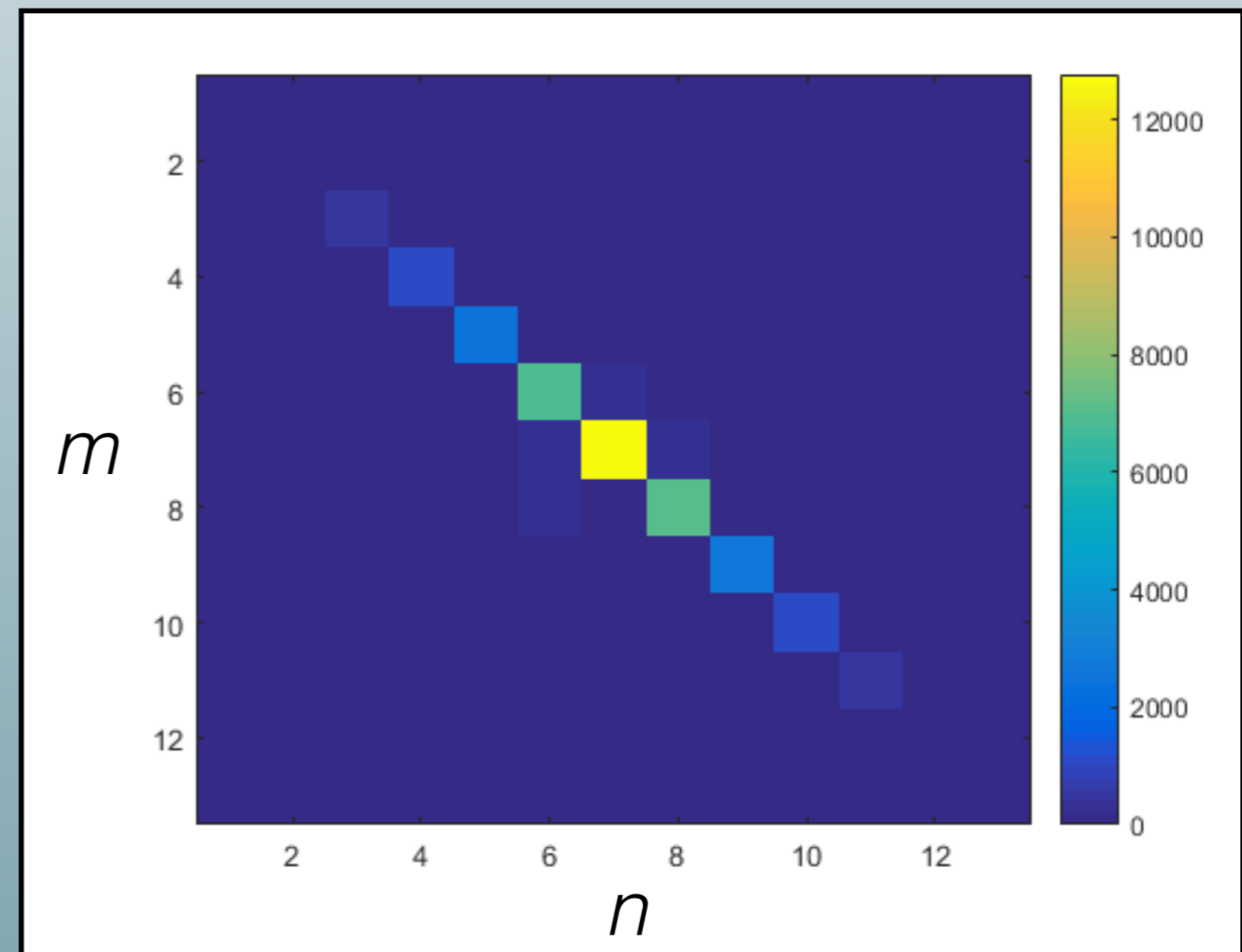


$$\tilde{F}(\rho, \Phi) \leq F(\rho, \Phi) \leq B_k(\Phi)$$

HOW TO CHOOSE $|\Phi\rangle$?

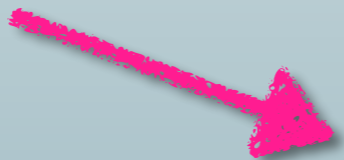
Choose *standard basis* $\{|mn\rangle\}$ and measure experimental (unknown) state ρ :

$$\langle mn|\rho|mn\rangle = \frac{N_{mn}}{\sum_{ij} N_{ij}}$$

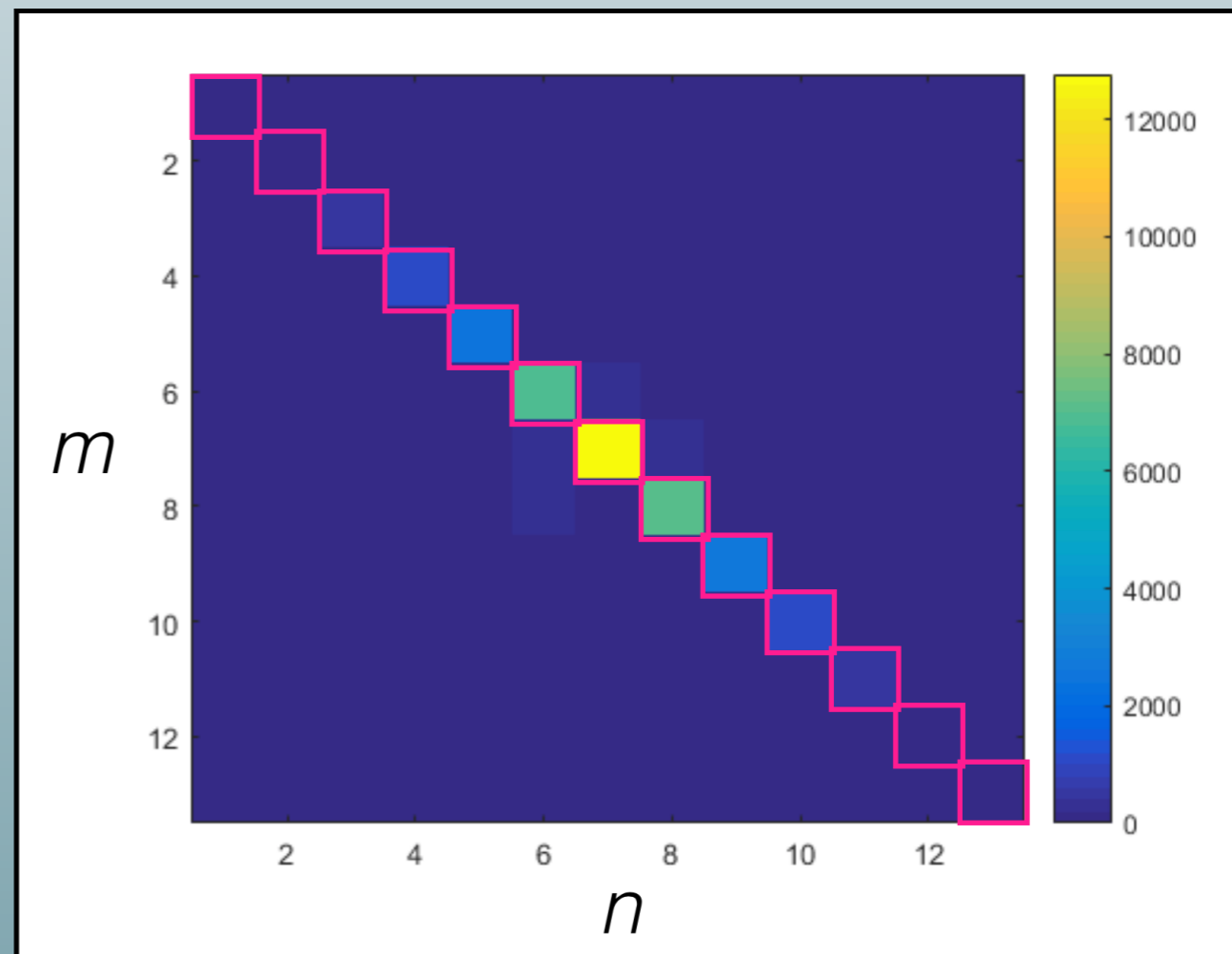


Calculate $\{\lambda_m\}$:

$$\lambda_m = \sqrt{\frac{\langle mm | \rho | mm \rangle}{\sum_n \langle nn | \rho | nn \rangle}}$$



2.

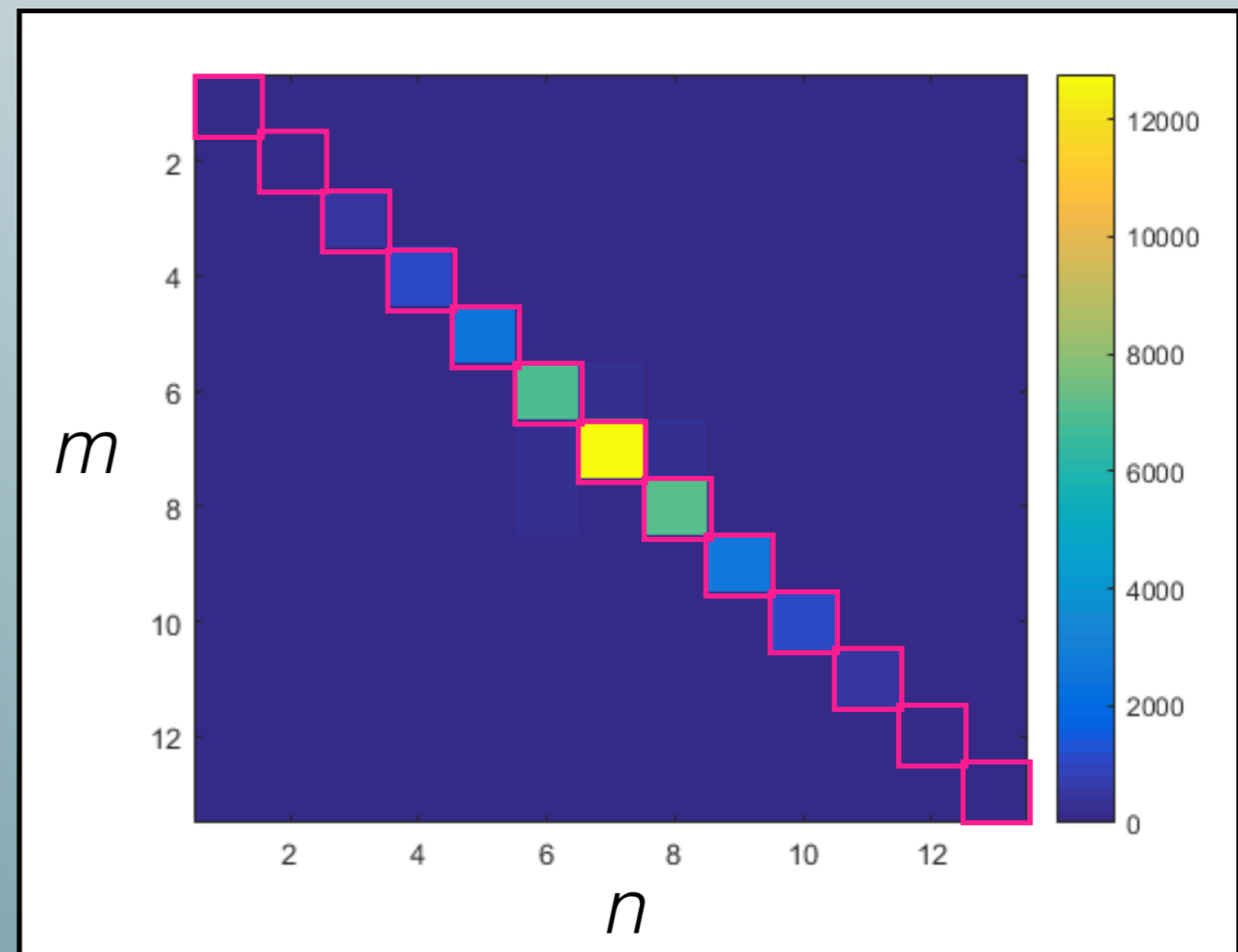


Define *tilted basis* $\{|\tilde{i}\tilde{j}^*\rangle\}$:

$$|\tilde{j}\rangle = \frac{1}{\sqrt{\sum_n \lambda_n}} \sum_{m=0}^{d-1} \omega^{jm} \sqrt{\lambda_m} |m\rangle$$

$$|\langle m|\tilde{j}\rangle|^2 = \lambda_m \lambda_j$$

2.

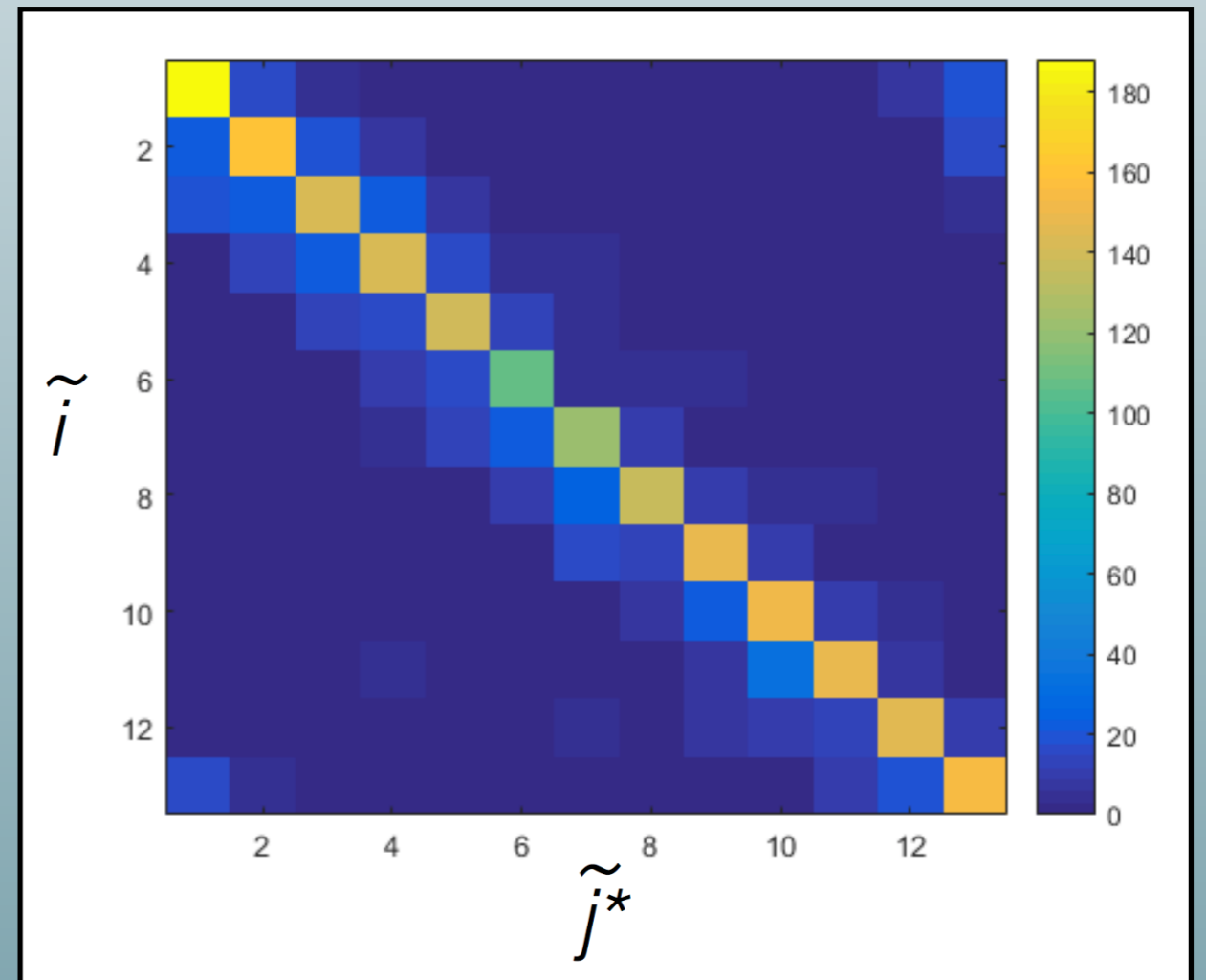


Measure in the tilted basis:

$$\langle \tilde{i}\tilde{j}^* | \rho | \tilde{i}\tilde{j}^* \rangle = \frac{\tilde{N}_{ij}}{\sum_{m,n} \tilde{N}_{mn}} c_\lambda$$

$$c_\lambda = \frac{d^2}{(\sum_k \lambda_k)^2} \sum_{m,n} \lambda_m \lambda_n \langle mn | \rho | mn \rangle$$

3.



Calculate fidelity lower bound and check witness:

$$\tilde{F}(\rho, \Phi) \leq F(\rho, \Phi) \leq B_k(\Phi)$$

$$\begin{aligned} \tilde{F}(\rho, \Phi) := & \frac{(\sum_k \lambda_k)^2}{d} \sum_j \langle \tilde{j} \tilde{j}^* | \rho | \tilde{j} \tilde{j}^* \rangle - \sum_{m, n \neq m} \lambda_m \lambda_n \langle mn | \rho | mn \rangle + \\ & - \sum_{\substack{m \neq n, m' \neq m, \\ n \neq n', n' \neq m', \\ m - n - m' + n' \bmod d \neq 0}} \sqrt{\lambda_m \lambda_{m'} \lambda_n \lambda_{n'}} \langle mn | \rho | mn \rangle \langle m'n' | \rho | m'n' \rangle \end{aligned}$$



Calculate fidelity lower bound and check witness:

$$\tilde{F}(\rho, \Phi) \leq F(\rho, \Phi) \leq B_k(\Phi)$$

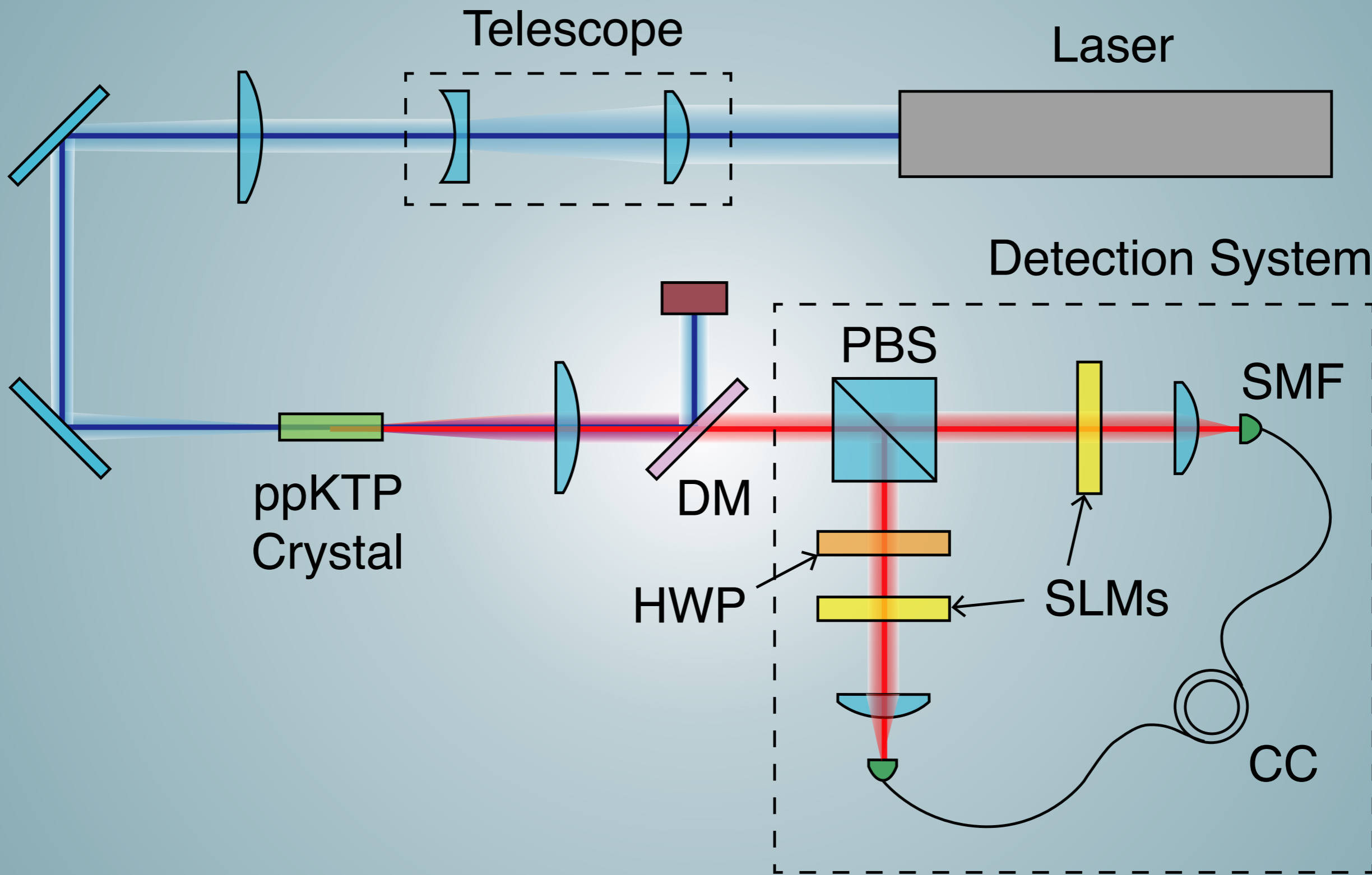
$$\tilde{F}(\rho, \Phi) > B_{k'}(\Phi) \implies k(\rho) = k' + 1$$

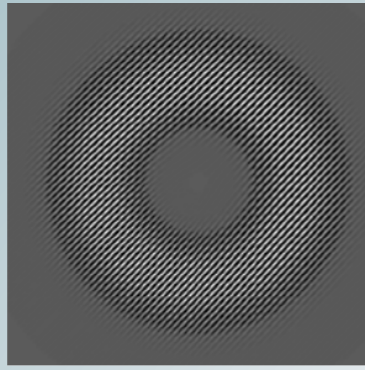


$$\tilde{F}(\rho, \Phi) \leq F(\rho, \Phi) \leq B_k(\Phi)$$

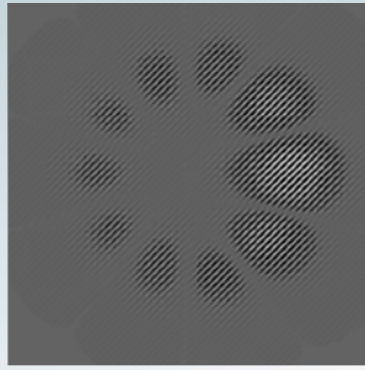
- Exact for pure states and dephased pure states.
- Generalized for M measurements.
- Exact in prime dimensions for $M=d+1$.
- Generalized for multipartite states.
- Provides lower bound for entanglement of formation.

EXPERIMENT

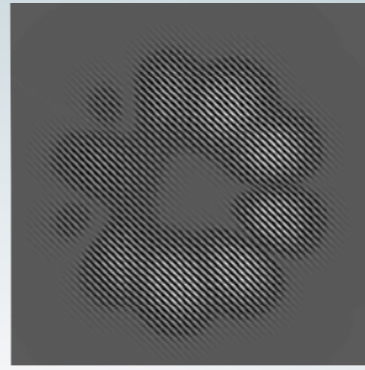




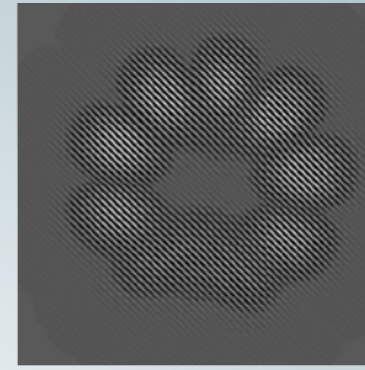
$\ell = -5$



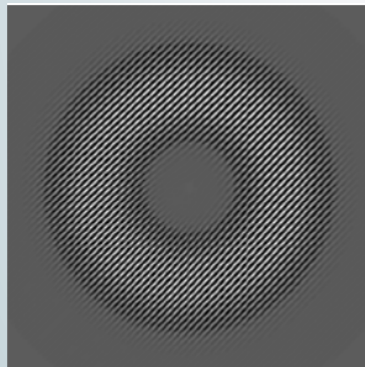
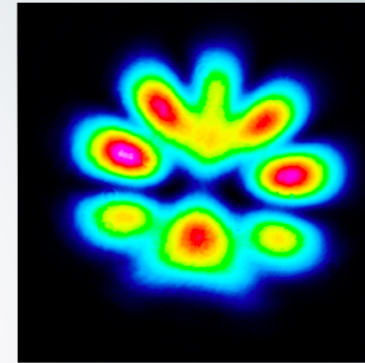
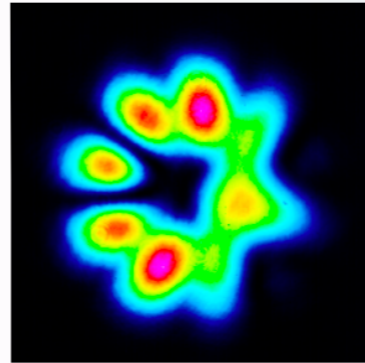
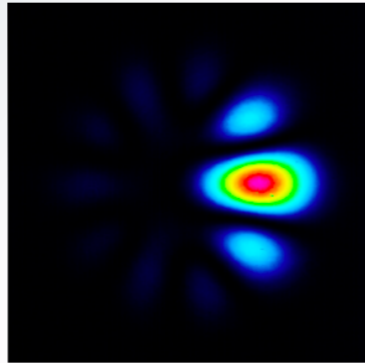
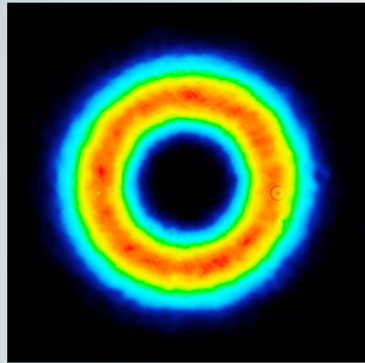
MUB1



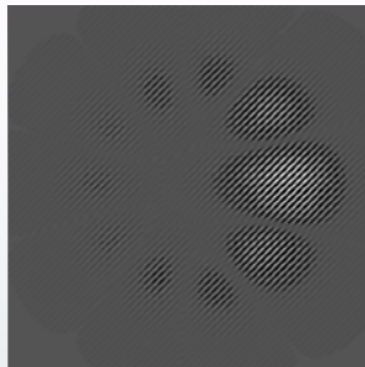
MUB2



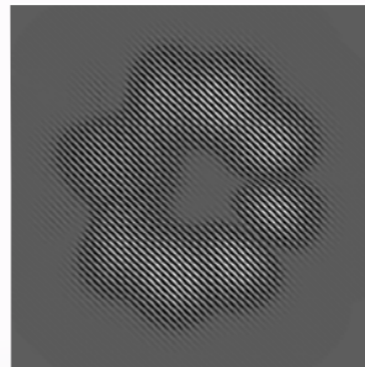
MUB3



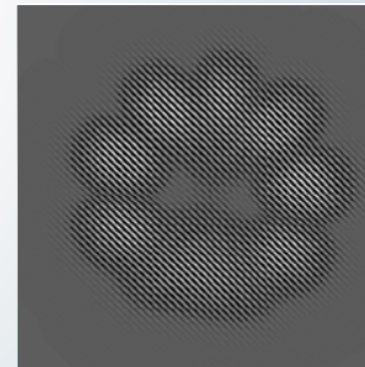
$\ell = -4$



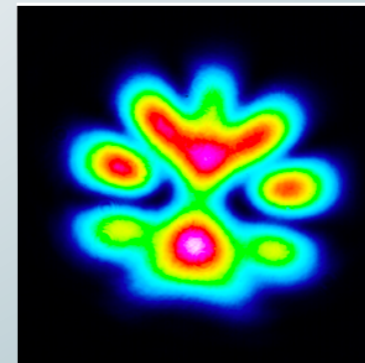
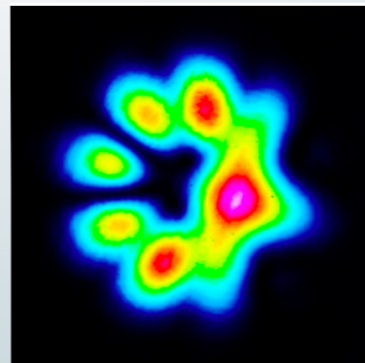
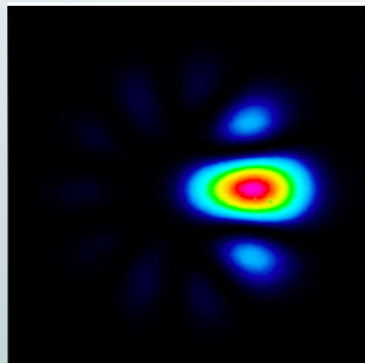
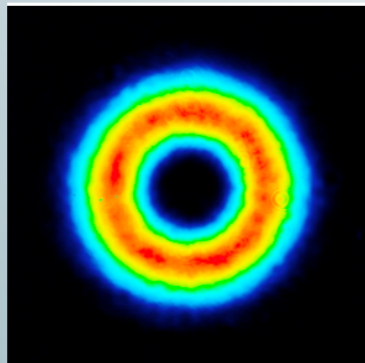
TILT1

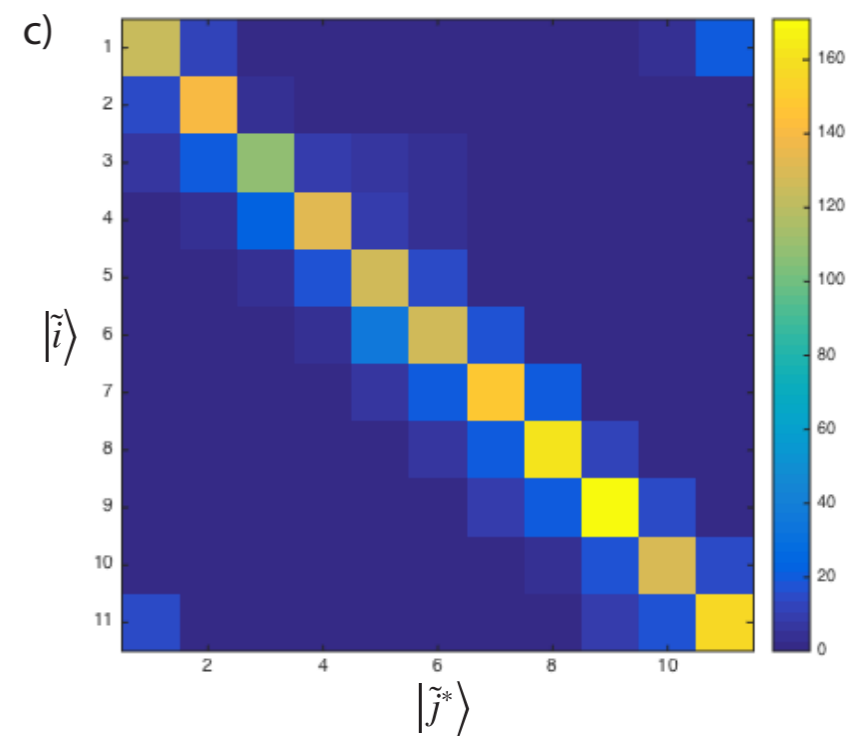
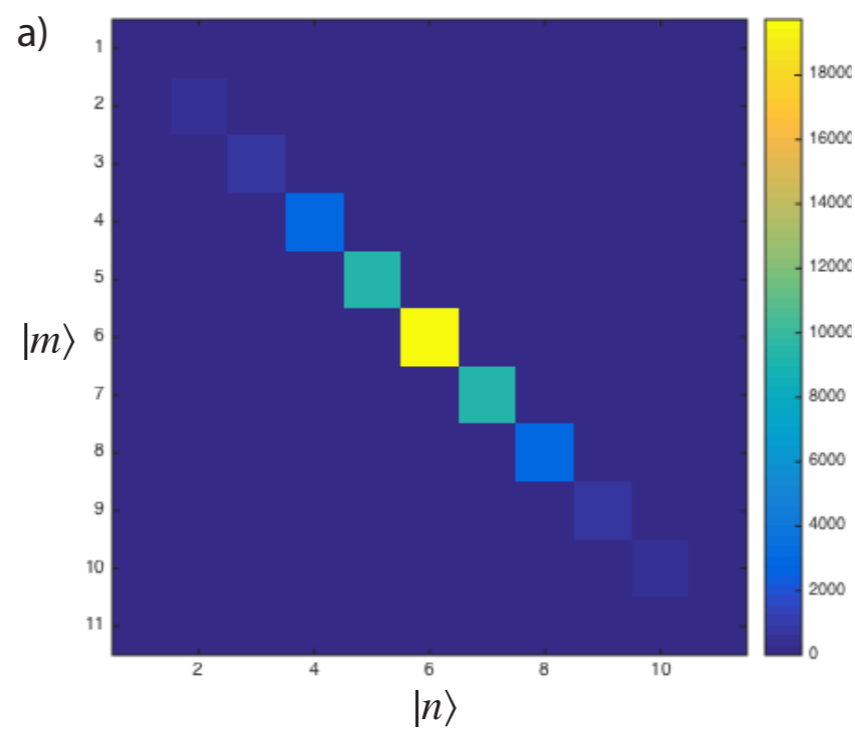
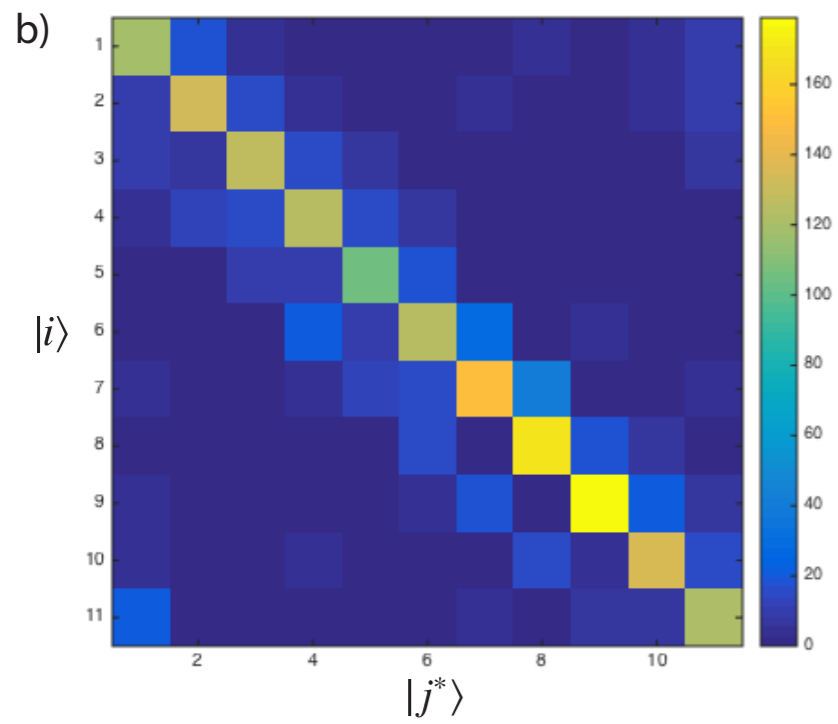


TILT2



TILT3





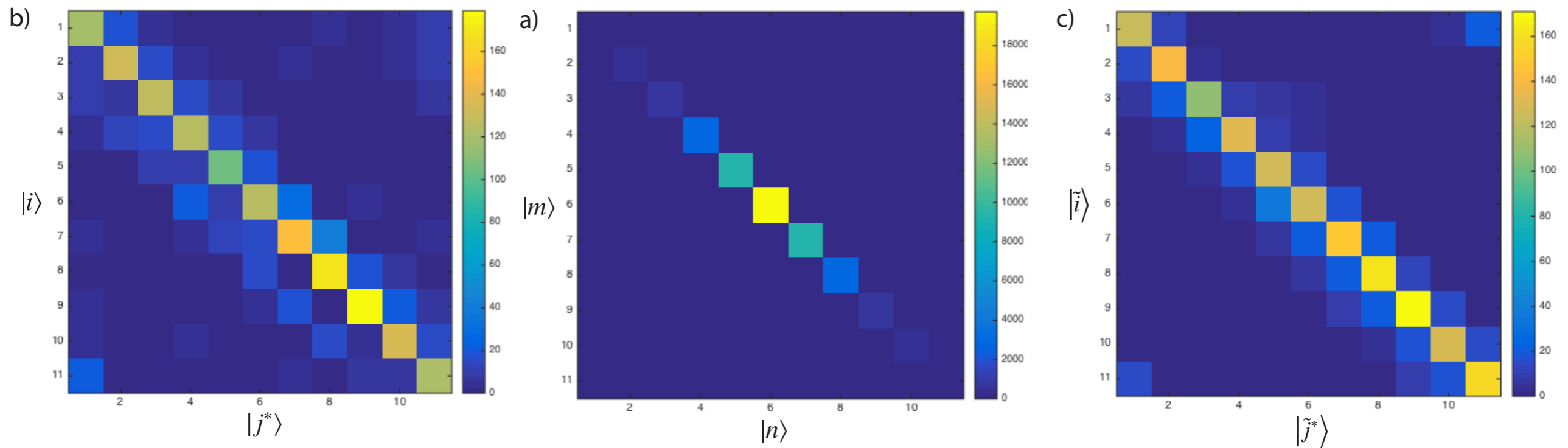
MUB

COMP. BASIS

TILTED BASIS

$$\tilde{F}(\rho, |\Phi^+\rangle)$$

$$\tilde{F}(\rho, |\Phi\rangle)$$



d	d_{ent}	$\tilde{F}(\rho, \Phi^+)$	$\tilde{F}(\rho, \Phi)$
3	3	$91.5 \pm 0.4\%$	$92.5 \pm 0.4\%$
5	5	$89.9 \pm 0.4\%$	$90.0 \pm 0.5\%$
7	6	$84.2 \pm 0.5\%$	$86.9 \pm 0.6\%$
11	9	$74.8 \pm 0.4\%$	$76.2 \pm 0.6\%$

SUMMARY OF RESULTS

THEORY

- Fidelity and Schmidt number certification with two measurements without assumptions on the state.

EXPERIMENT

- Highest Schmidt number ($k=9$) ever certified without assumptions on the state.

THANK YOU!

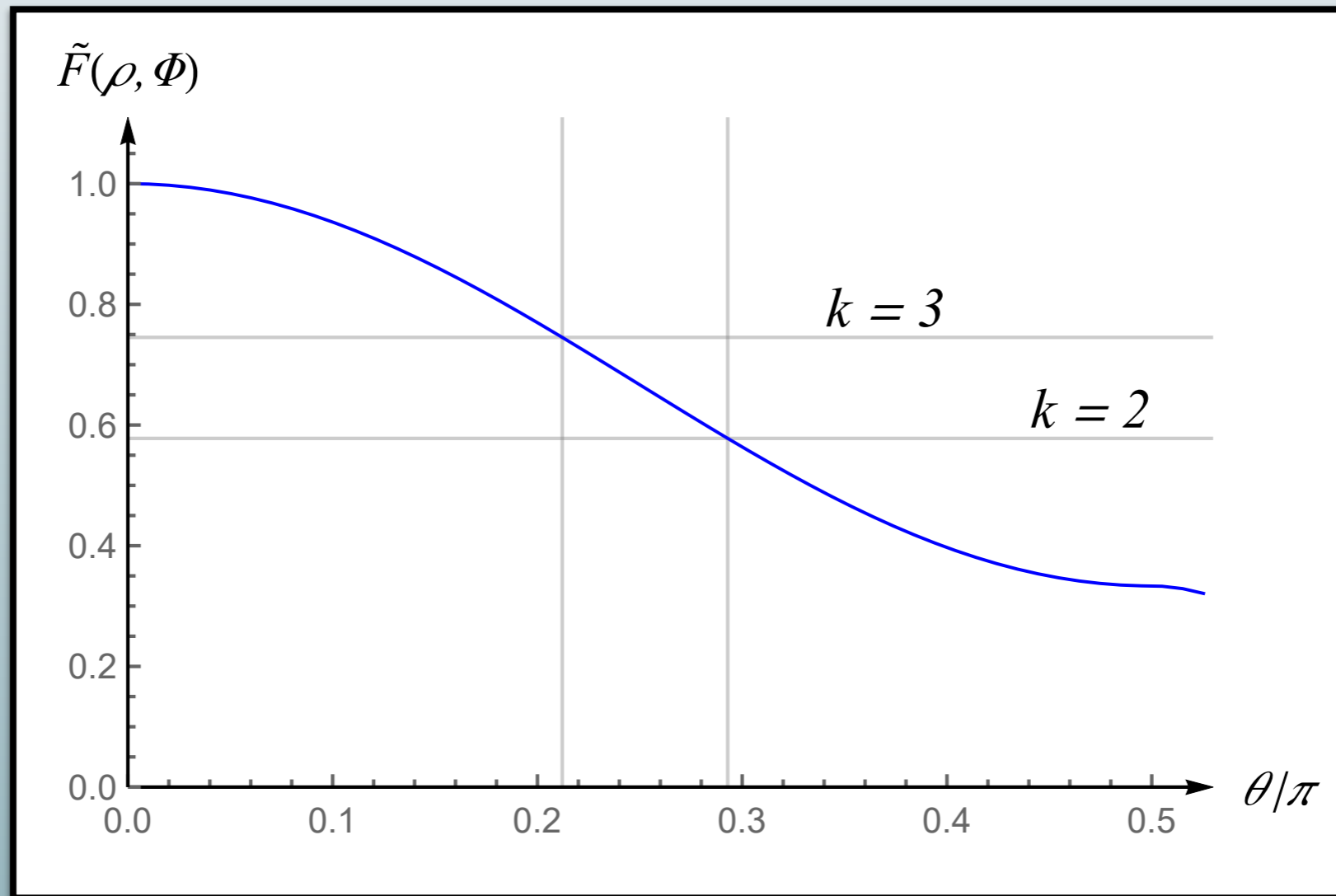
EXTRA SLIDES

$$|\tilde{j}\rangle = \frac{1}{\sqrt{\sum_n \lambda_n}} \sum_{m=0}^{d-1} \omega^{jm} \sqrt{\lambda_m} |m\rangle$$

$$\sum_{i,j} \langle \tilde{i} \tilde{j}^* | \rho | \tilde{i} \tilde{j}^* \rangle = \frac{d^2}{(\sum_k \lambda_k)^2} \sum_{m,n} \lambda_m \lambda_n \langle mn | \rho | mn \rangle$$

$$c_\lambda :=$$

DEVIATION OF THE SCHMIDT BASIS



NOISE RESISTANCE

